

**Search Notes**

Application/Control No.

10/685,599

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

SHIROTA ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	315-317	3/6/2005	TT
257	319-321	3/6/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR